

Form PTO 1449  
(Modified)U.S. DEPARTMENT OF COMMERCE  
PATENT AND TRADEMARK OFFICE

ATTY DOCKET NO.

214607US2

SERIAL NO.

09/964,585

## LIST OF REFERENCES CITED BY APPLICANT

APPLICANT

Toyoji IKEZAWA, et al.

FILING DATE

September 28, 2001

GROUP

2171

## U.S. PATENT DOCUMENTS

EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA						
	AB						
	AC						
	AD						
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	AH						
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	AM						
	AN						

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## FOREIGN PATENT DOCUMENTS

		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION	
					YES	NO
<i>Edik</i>	AO	2001-250022	09/14/2001	JAPAN (with English translation)		
<i>↓</i>	AP	2000-242724	09/08/2000	JAPAN (with English translation)		
<i>↓</i>	AQ	9-160979	06/20/97	JAPAN (with English translation)		
<i>↓</i>	AR	9-6838	01/10/97	JAPAN (with English translation)		
	AS					
	AT					
	AU					
	AV					

## OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)

	AW	
	AX	
	AY	
	AZ	

☐ Additional References sheet(s) attached

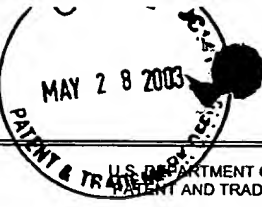
Examiner

*E. P. Lehoucq*

Date Considered

2/12/04

\*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.



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LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Toyoji IKEZAWA, et al.			
				FILING DATE September 28, 2001		GROUP 2171	
U.S. PATENT DOCUMENTS							
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO		
<i>Elh</i>	AO	10-011498	01/16/98	JAPAN (with English Abstract)			X
<i>Elh</i>	AP	07-230442	08/29/95	JAPAN (with English Abstract)			X
<i>Elh</i>	AQ	2000-222486	08/11/2000	JAPAN (with English Abstract)			X
	AR						
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ						<input type="checkbox"/> Additional References sheet(s) attached
Examiner <i>SP Lihana</i>					Date Considered <i>2/12/04</i>		
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